

<b>Notice of References Cited</b>	Application/Control No. 10/551,476		Applicant(s)/Patent Under Reexamination JOHNS ET AL.	
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*	C	US-6,165,284 A	12-2000	Shubkin, Ronald L.	134/38
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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